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Finite Element Model Levelling for Material Model Calibration using Digital Image Correlation

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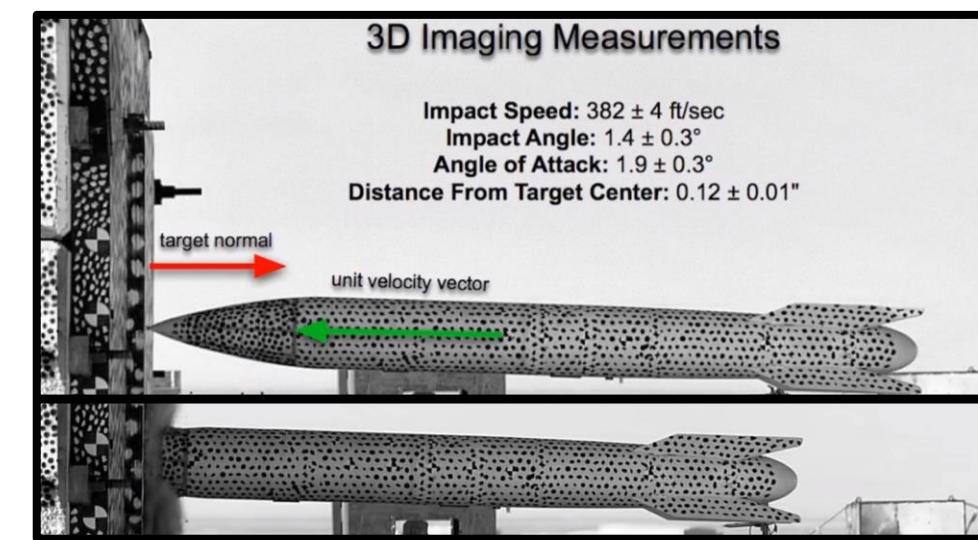
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Background and Motivation

Background:

- Computational simulation to reduce expensive experimentation.
- Simulation accuracy is crucial, requiring robust calibration.
- Accuracy is enabled by robust measurements via digital image correlation (DIC) and inverse parameter identification techniques such as finite element model updating (FEMU).



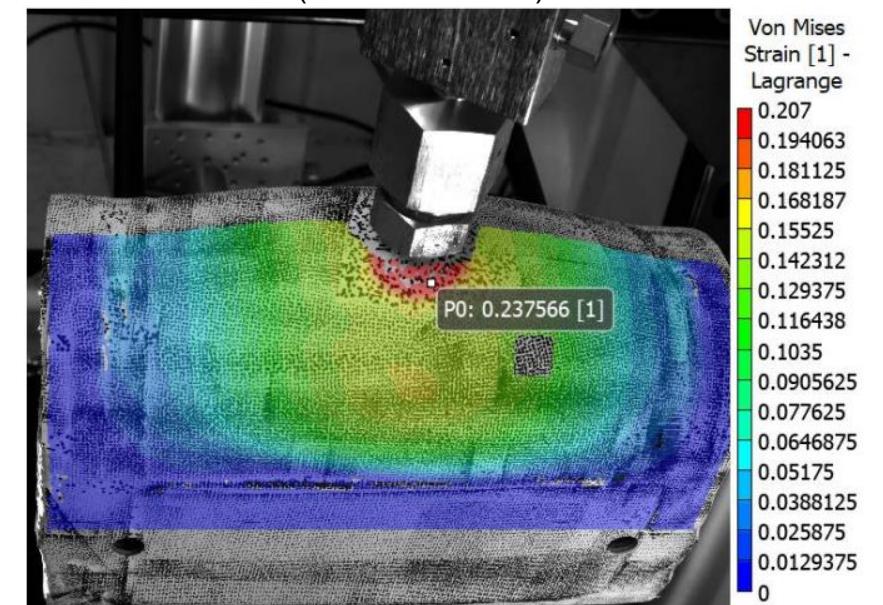
Sandia National Labs Ballistic Rocket Sled Test
(December 2015)

Problem:

- DIC-measured strains suffer from a filtering bias caused by estimating the average strain across an area called a **virtual strain gage (VSG)**.

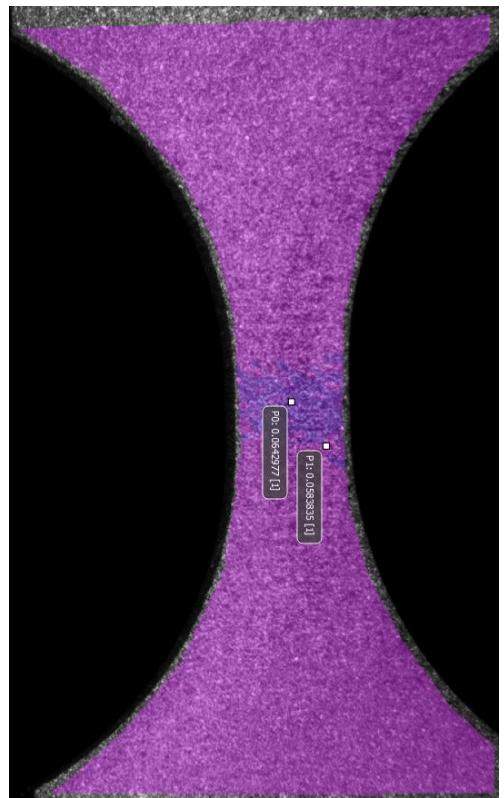
Goal:

- We seek to account for the mismatch between the strains calculated through FEA and measured via DIC for the purpose of material model calibration.

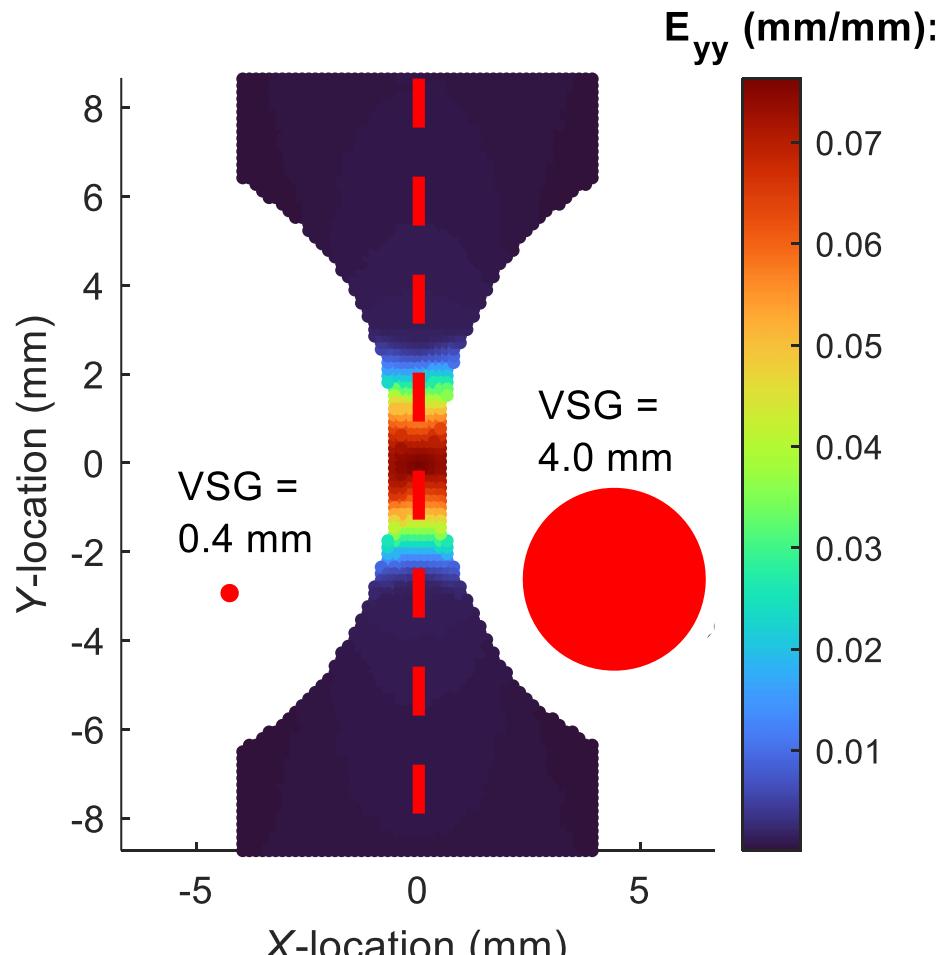


Lance, BW, & Carlson, MD. "Compact Heat Exchanger Semi-Circular Header Burst Pressure and Strain Validation." Proceedings of the ASME Turbo Expo 2019

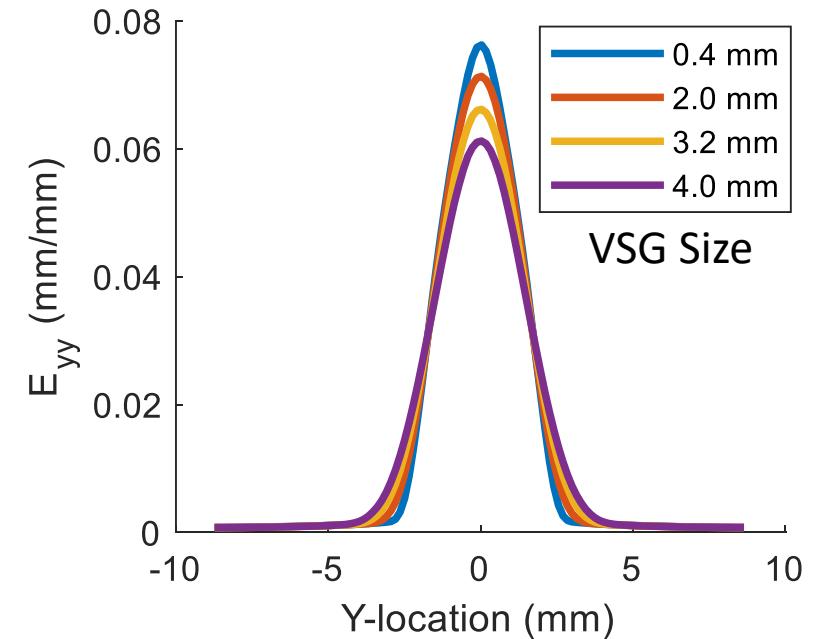
DIC experiences length-scale dependent filtering biases



304L hourglass specimen
subjected to uniaxial tension

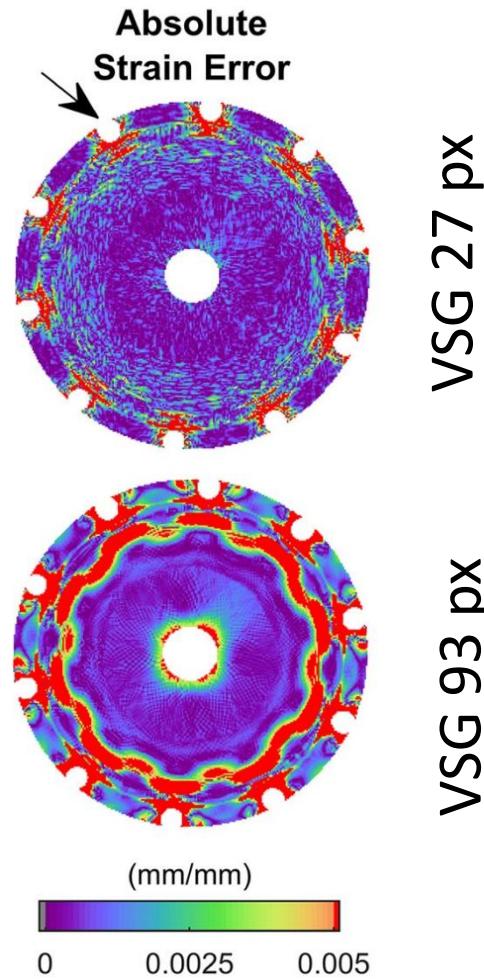


DIC results for a synthetic
experiment.



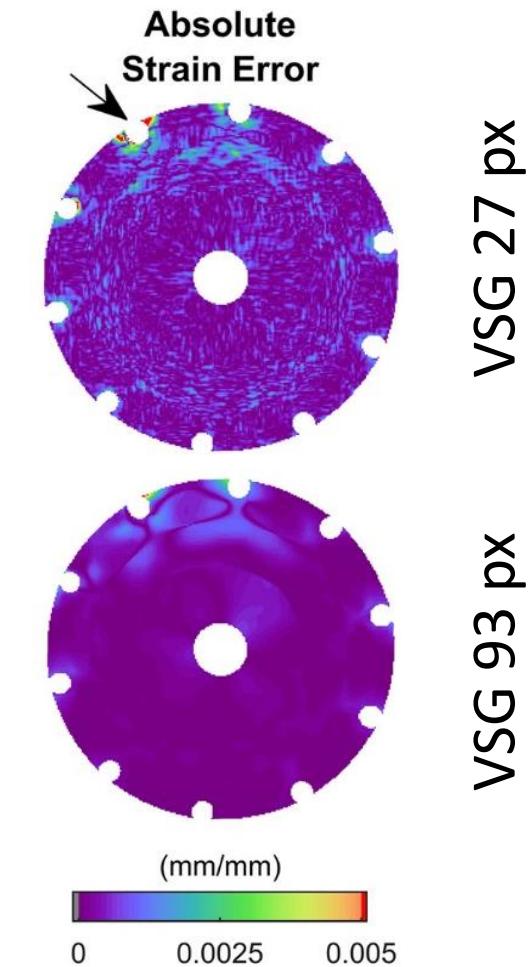
Sampled linecuts of the y-strain.
Larger VSG sizes correspond to
strain attenuation

The filtering causes a mismatch between FEA and DIC



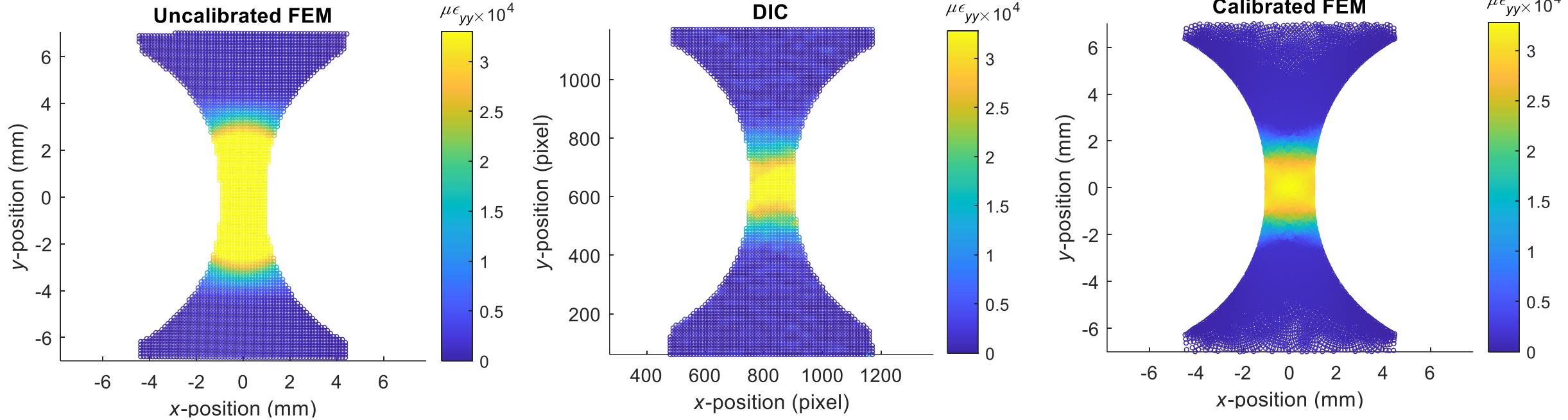
Discrepancy caused by
mismatch of resolution
between FEA and DIC

Comparison of strains
after processing the
FEA through a DIC
simulator.



Lava P, Jones EMC, Wittevrongel L, Pierron F, (2020) Validation of finite-element models using full-field experimental data: Levelling finite-element analysis data through a digital image correlation engine. *Strain* 56(4): e12350. <https://doi.org/10.1111/str.12350>

Finite Element Model Updating (FEMU)



FEMU Objective Function

$$\chi_u^2(\{\mathbf{p}\}) = \frac{1}{N_\epsilon} \sum_{i=1}^{N_\epsilon} (\{\epsilon_m\} - \{\epsilon_c\})^2$$

$$\min_{\mathbf{p}} \chi_u^2(\{\mathbf{p}\})$$

Newton-Raphson Optimization

$$\delta \mathbf{p} = [\mathbf{H}^{i-1}]^{-1} [\mathbf{S}]^t (\{\epsilon_m\} - \epsilon_c(x, \{\mathbf{p}^{i-1}\}))$$

ϵ_m : the DIC measured strain

ϵ_c : the FEM calculated strain

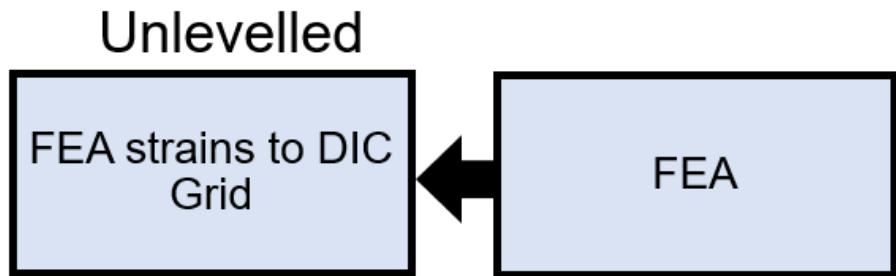
N_ϵ : the number of strain measurements

$[\mathbf{H}]$: the Hessian matrix $[\mathbf{H}^i] = [\mathbf{S}^i]^t [\mathbf{S}^i]$

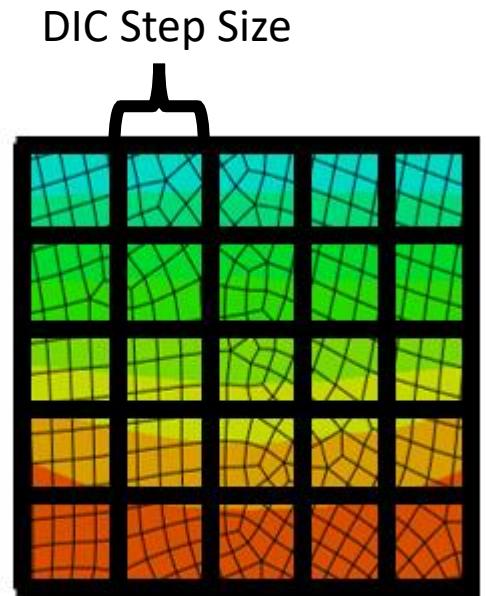
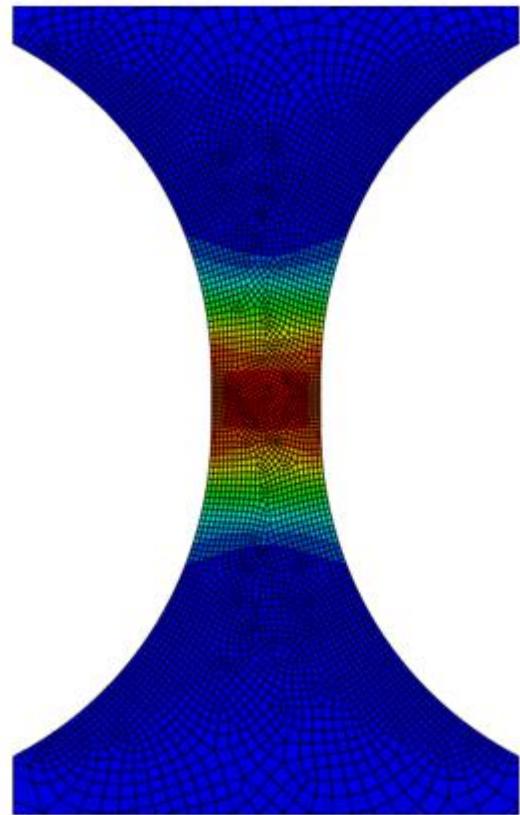
$[\mathbf{S}]$: the sensitivity matrix $[\mathbf{S}] = \frac{\partial(\epsilon_{FEM}^i)}{\partial p_j}$

Mathieu, F., Leclerc, H., Hild, F. et al. Estimation of Elastoplastic Parameters via Weighted FEMU and Integrated-DIC. *Exp Mech* 55, 105–119 (2015). <https://doi.org/10.1007/s11340-014-9888-9>

Direct interpolation of FEA strain (ie unlevelled) for comparison is ill-advised



ABAQUS Logarithmic Y-Strain



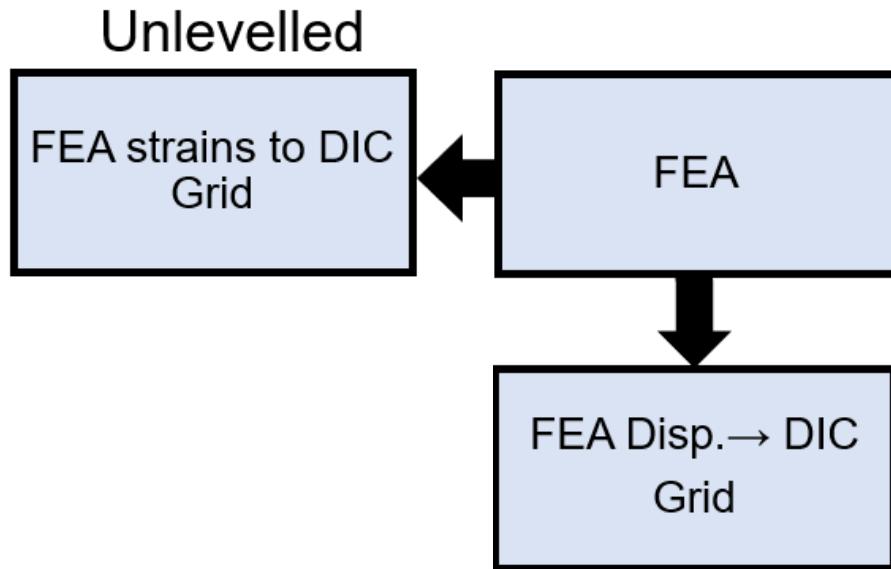
Strains computed using different:

- Calculation method
- Spatial resolution
- Tensor!

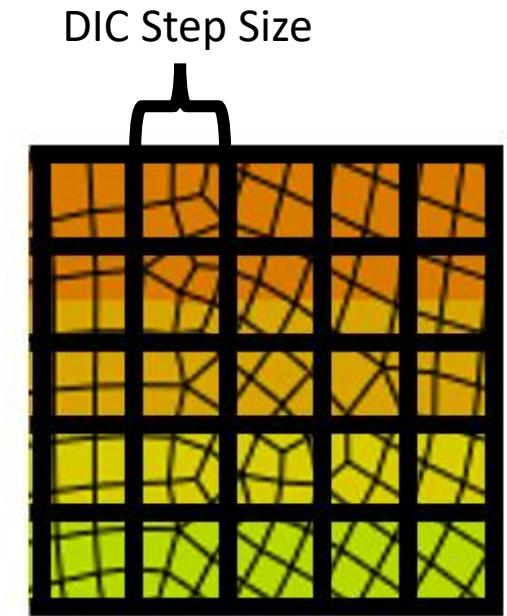
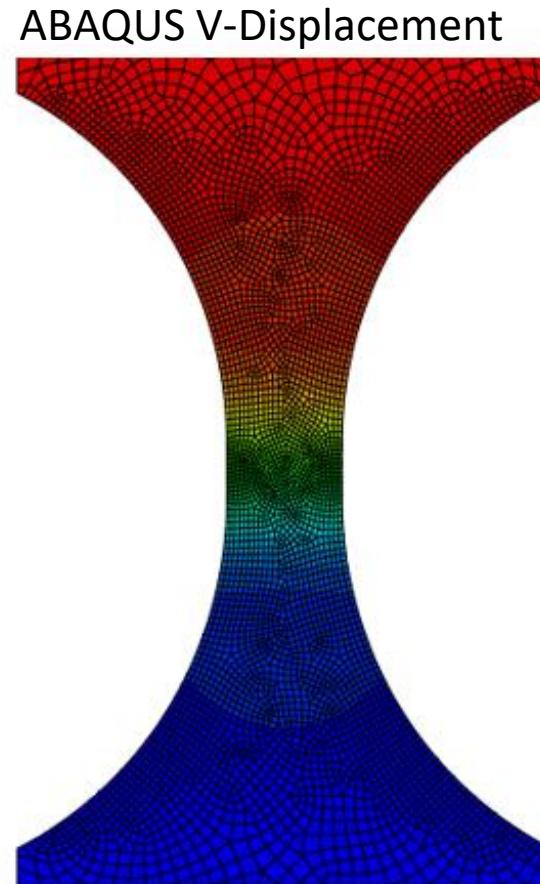
Logarithmic Strain (ABAQUS)

$$\boldsymbol{\varepsilon} = \ln(\sqrt{\mathbf{B}}) = \ln(\sqrt{\mathbf{F} \cdot \mathbf{F}^T})$$

Direct interpolation of displacement is better

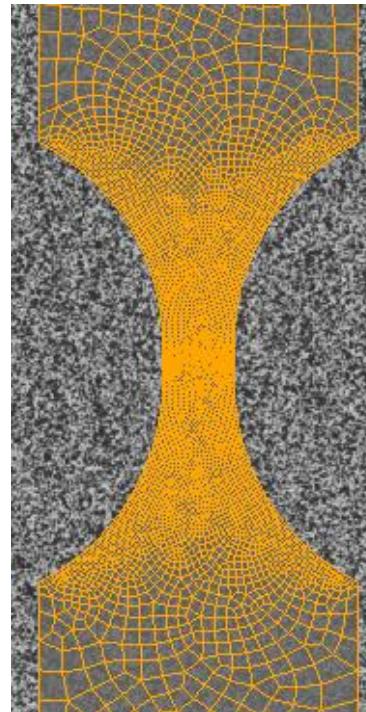
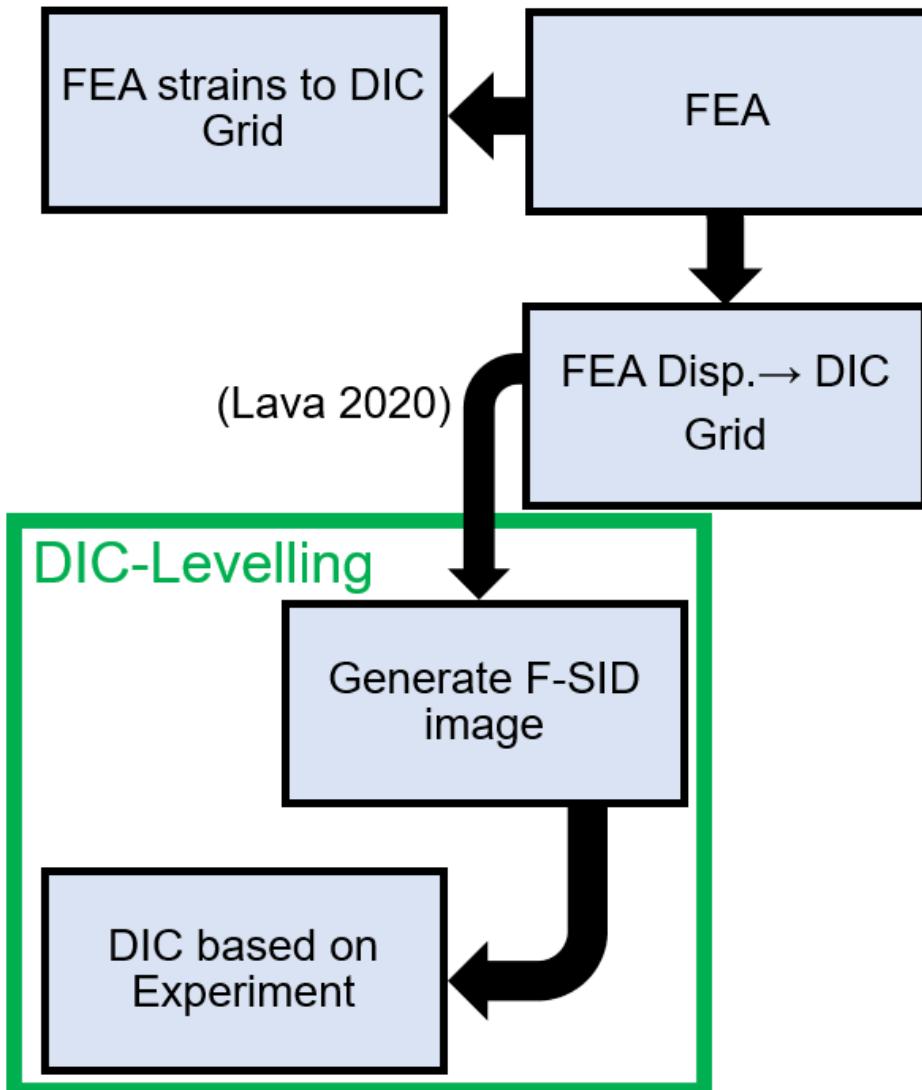


The FEM data is uncorrupted with only small errors due to registering to DIC grid.

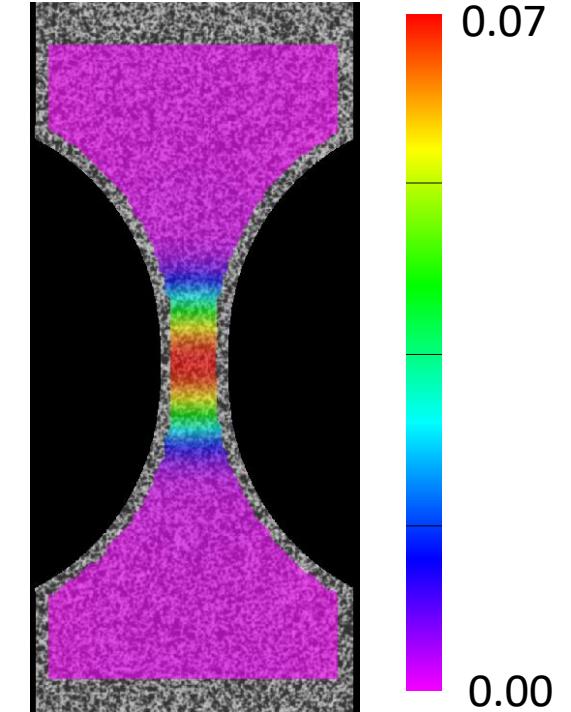


DIC-Levelling corrects for DIC errors

Unlevelled



Mesh to pattern alignment

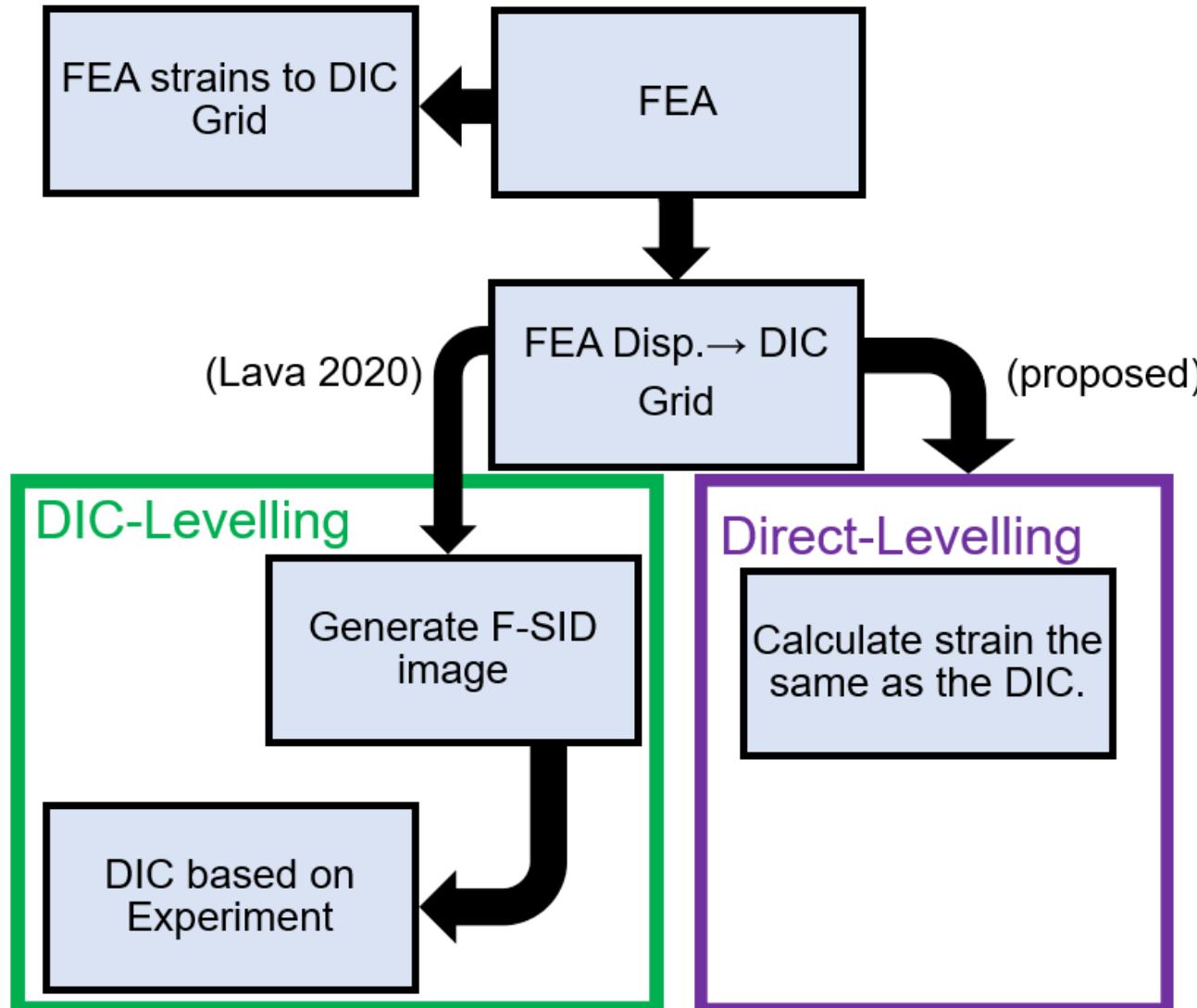


DIC Analysis of F-SID image

Rectifies issues with strain calculation, spatial resolution, and image based errors such as interpolation bias, image discretization, PIB. Does not account for image noise.

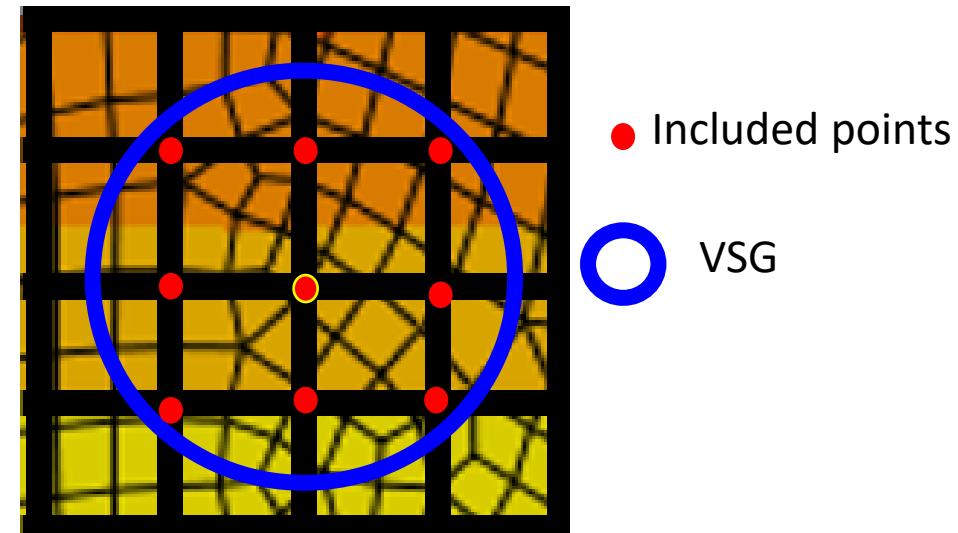
Direct-levelling the FEA output as a simple solution

Unlevelled



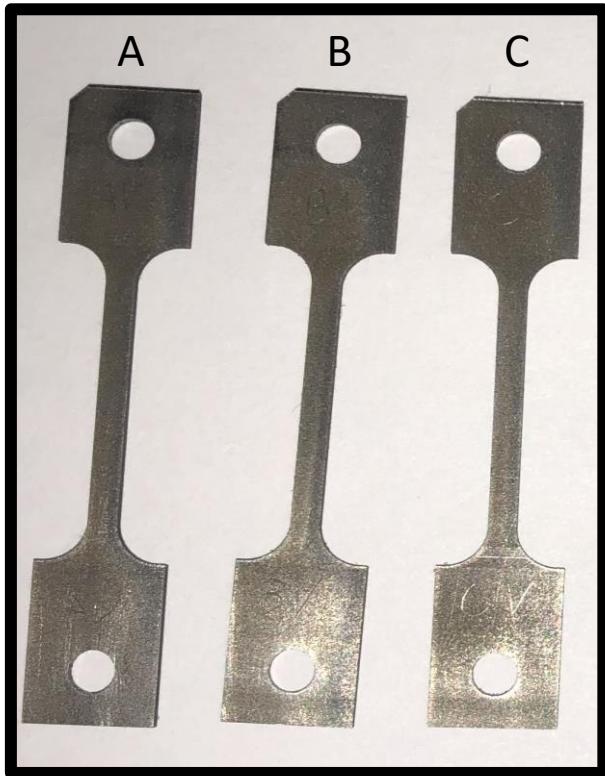
Calculate the Green-Lagrange Strain Tensor via the polynomial shape function method

$$E_{KL} = \frac{1}{2} \left(\frac{\partial x_j}{\partial X_K} \frac{\partial x_j}{\partial X_L} - \delta_{KL} \right)$$

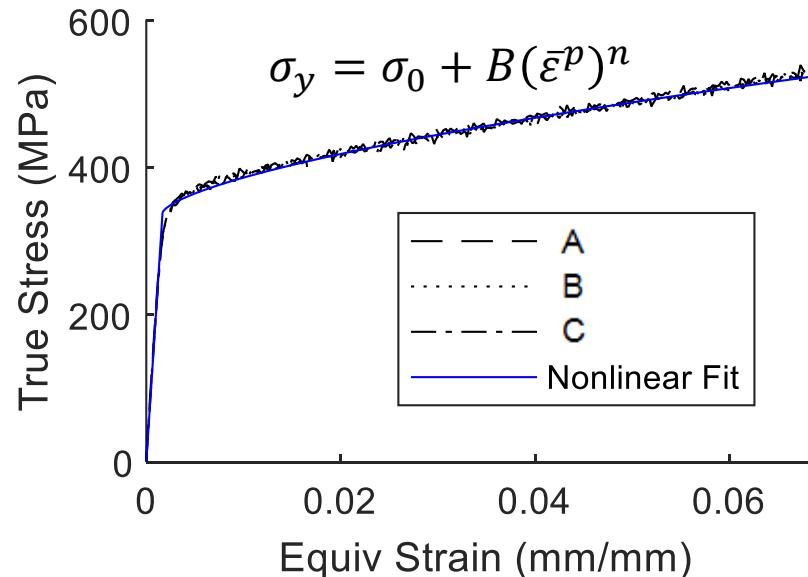


Material Model for FE Model

304L stainless steel tensile specimens



Material hardening is given by the power law:



Material model parameters

$$E = 200 \text{ GPa}$$

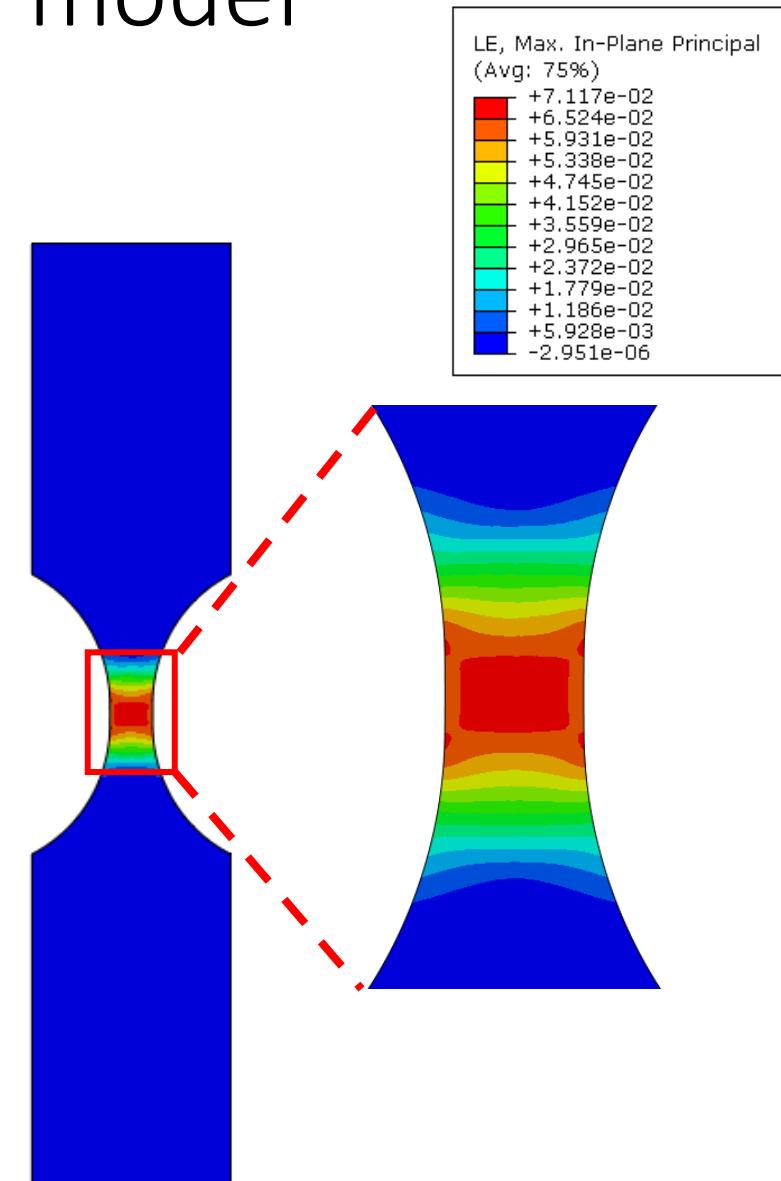
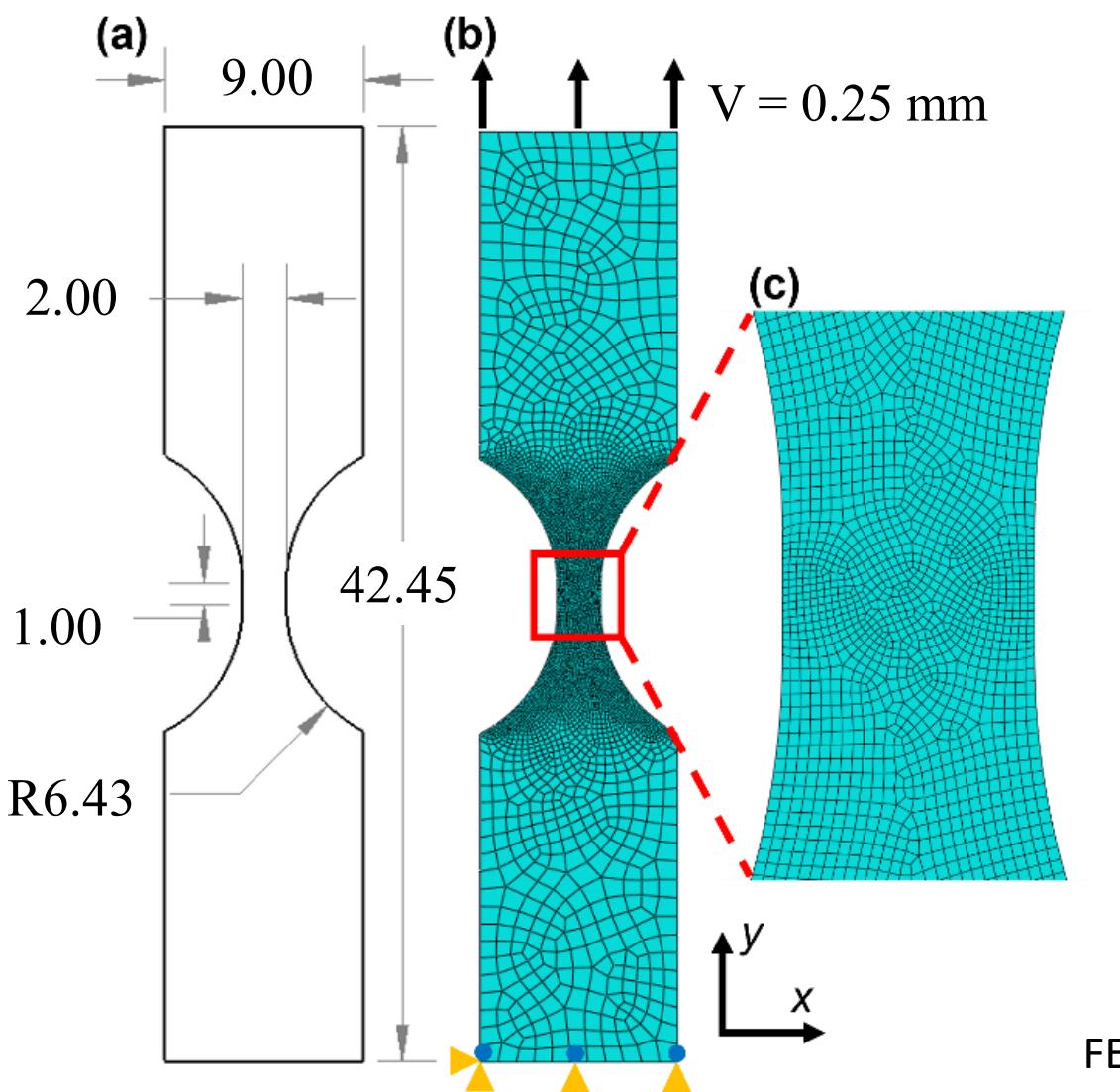
$$\nu = 0.29$$

$$\sigma_0 = 339 \text{ MPa}$$

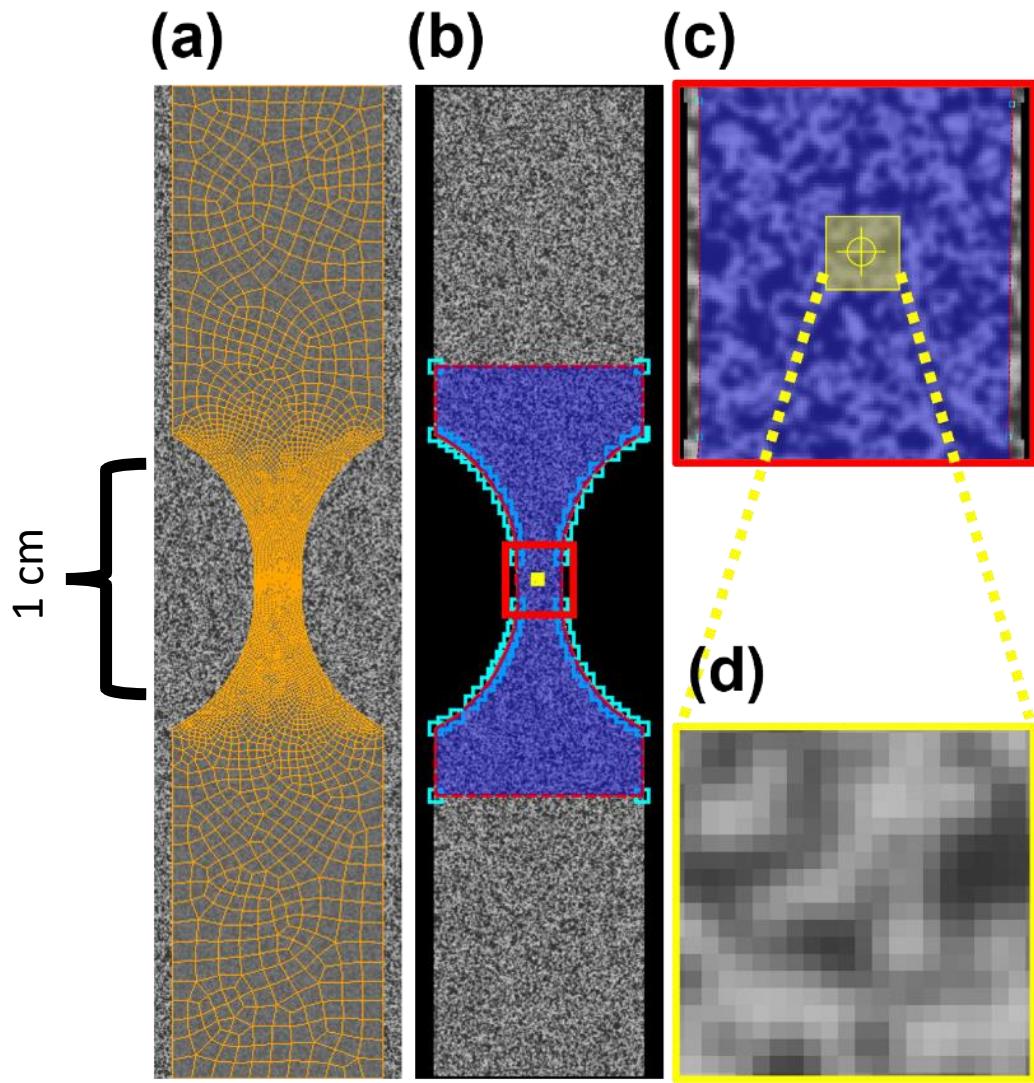
$$B = 1.07 \text{ GPa}$$

$$n = 0.645$$

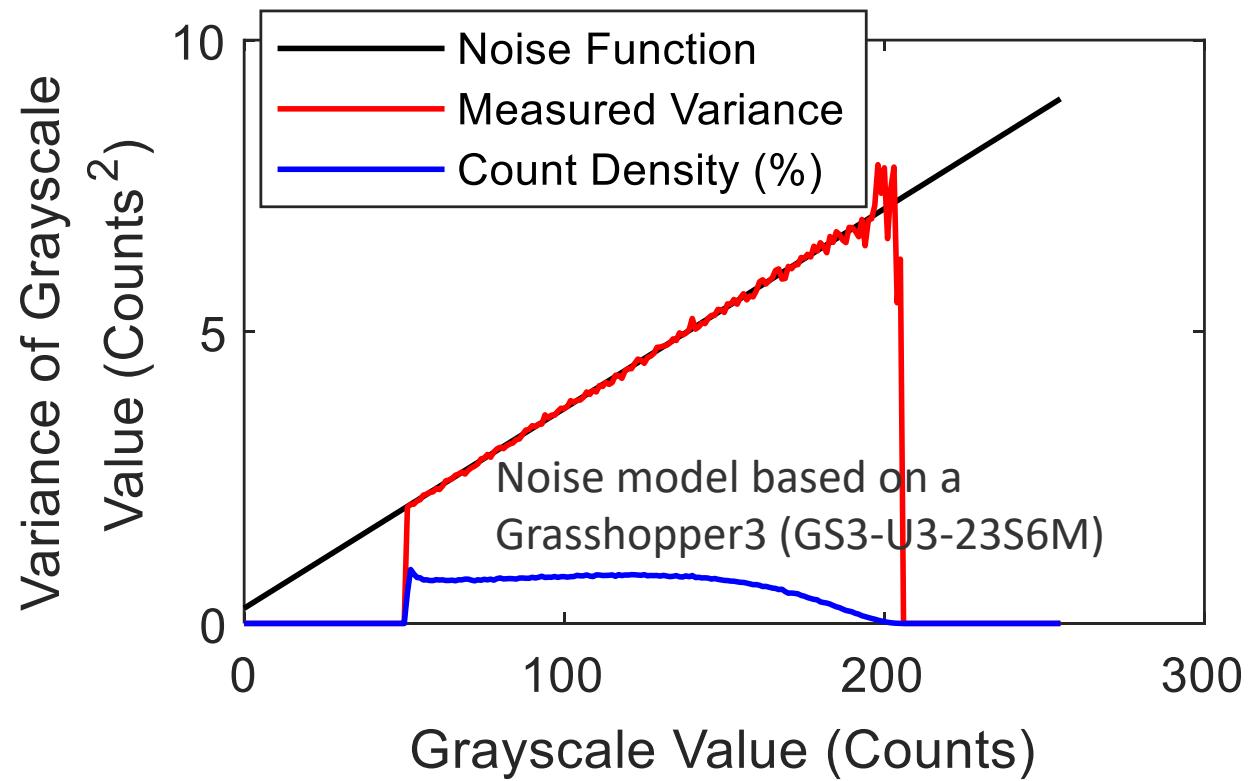
FEMU Calibration via direct-levelling: FE model



Generation of Synthetic Images as “experimental” data



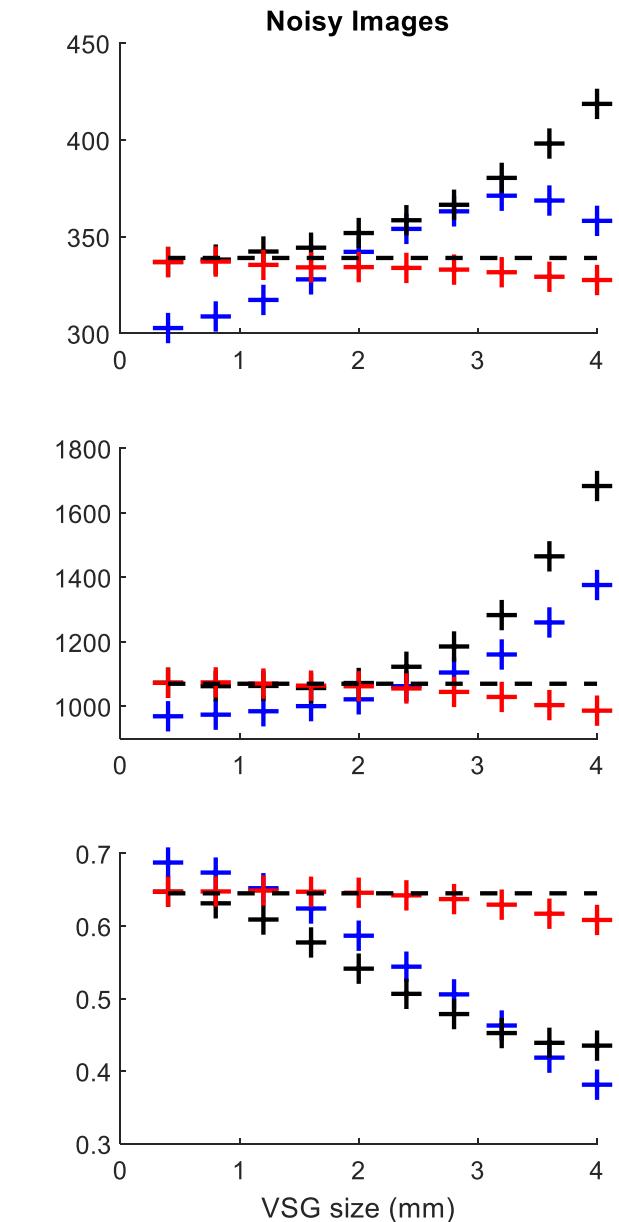
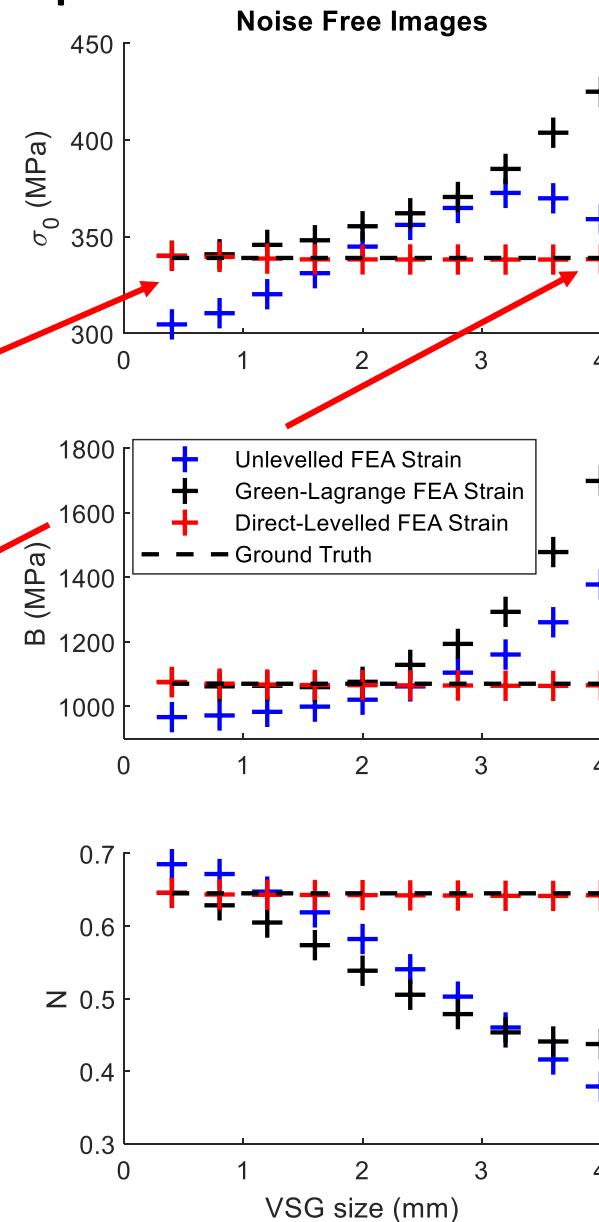
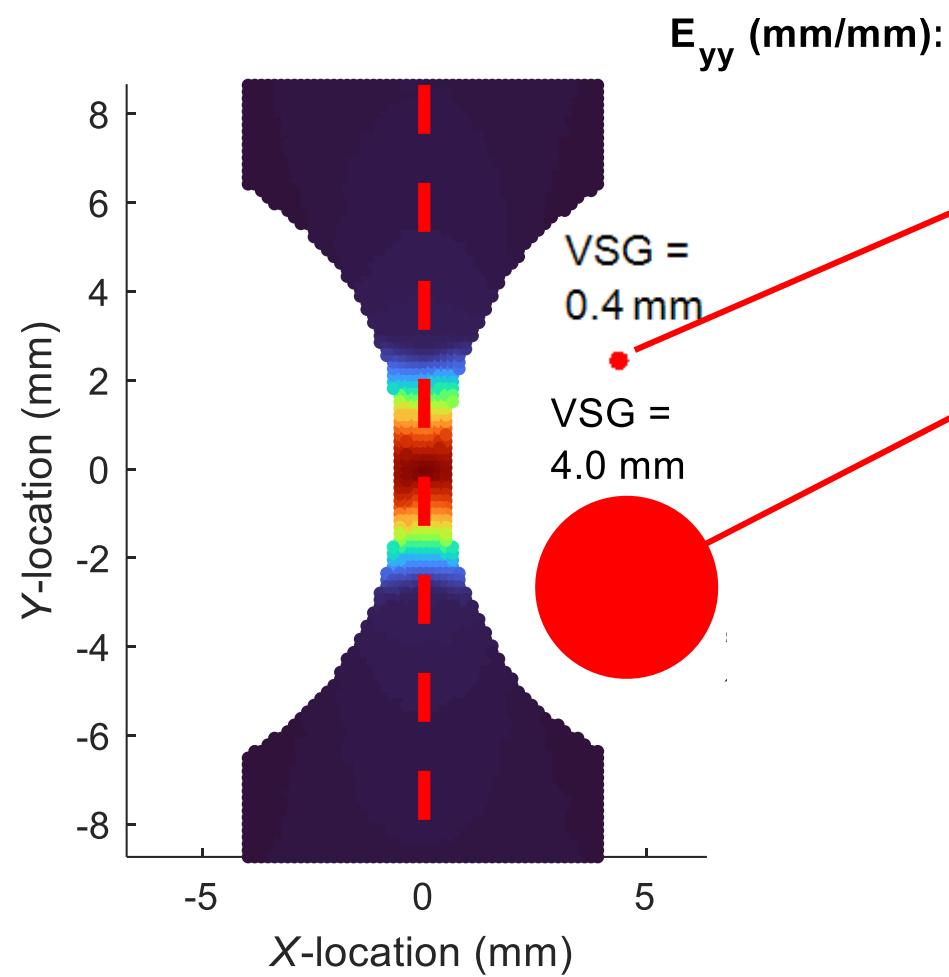
Deformation done by MatchID FEDEF module



DIC Settings

Subset Size	Step Size	Shape Function	Criterion	Image Interpolant
21 px	7 px	Quadratic	ANSSD	Bicubic Spl.

Effect of direct-levelling on parameter identification



Conclusions and Future Work

Summary

- The errors due to the filtering effect of DIC can cause false errors when comparing DIC to FEA
- Properly levelling the FEM to the DIC results is important for an accurate calibration.
- Direct-levelling as opposed to full DIC-levelling is sufficient to obtain an accurate FEMU identification

Limitations

This method does not account for image-induced errors which we show is small compared to the filtering effects of DIC.

Identification errors using a DIC VSG of 0.8 mm

Levelling		Unlevelled	Direct-Levelled
σ_0	Noise Free	8.42%	-0.15%
B		9.19%	-0.03%
n		-4.12%	0.26%
σ_0	Noisy	8.92%	0.55%
B		8.96%	-0.39%
n		-4.43%	-0.40%

Identification errors have been reduced more than **10X** for the identification results using noisy images

Supplemental Slides: Identification Errors

DIC Shape		Quadratic		Quadratic		Quadratic		Affine		Affine		Quadratic	
Fun.													
DIC Step		7		7		7		7		7		2	
Size (pixels)													
Levelling		UL		TL		SL		SL		SSL & SL		SL	
σ_0	Noise Free	8.42%	-0.56%	-0.15%	0.76%	0.16%						0.04%	
B	Noise Free	9.19%	0.76%	-0.03%	1.20%	0.40%						0.11%	
n	Noise Free	-4.12%	2.56%	0.26%	2.03%	0.37%						0.21%	
σ_0	Noisy	8.92%	0.24%	0.55%	1.28%	0.68%						0.40%	
B	Noisy	8.96%	0.70%	-0.39%	0.58%	-0.31%						-0.36%	
n	Noisy	-4.43%	2.13%	-0.40%	1.16%	-0.54%						-0.25%	